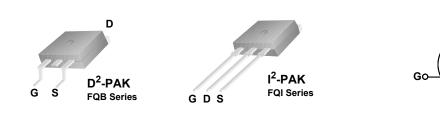
FAIRCHILD October 2008 SEMICONDUCTOR **QFET**[®] FQB32N20C/FQI32N20C 200V N-Channel MOSFET **General Description** Features 28A, 200V, $R_{DS(on)}$ = 0.082 Ω @V_{GS} = 10 V Low gate charge (typical 82.5 nC) These N-Channel enhancement mode power field effect • transistors are produced using Fairchild's proprietary, • planar stripe, DMOS technology. Low Crss (typical 185 pF) • This advanced technology has been especially tailored to

minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction, electronic lamp ballasts based on half bridge topology.

- · Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- RoHS Compliant



FQB32N20C/FQI32N20C



Absolute Maximum Ratings T_C = 25°C unless otherwise noted

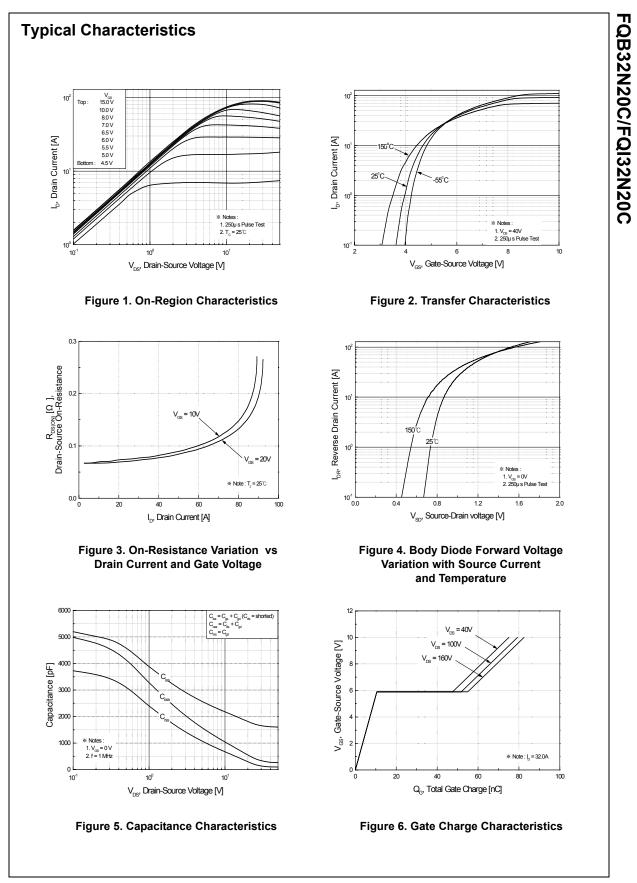
Symbol	Parameter		FQB32N20C / FQI32N20C	Units
V _{DSS}	Drain-Source Voltage		200	V
I _D	Drain Current - Continuous (T _C = 25°	Drain Current - Continuous (T _C = 25°C)		А
	- Continuous (T _C = 100°C)		17.8	А
I _{DM}	Drain Current - Pulsed	(Note 1)	112	А
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	955	mJ
I _{AR}	Avalanche Current	(Note 1)	28.0	А
E _{AR}	Repetitive Avalanche Energy	(Note 1)	15.6	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	5.5	V/ns
	Power Dissipation $(T_A = 25^{\circ}C)^*$		3.13	W
PD	Power Dissipation (T _C = 25°C)		156	W
	- Derate above 25°C		1.25	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
Τ _L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

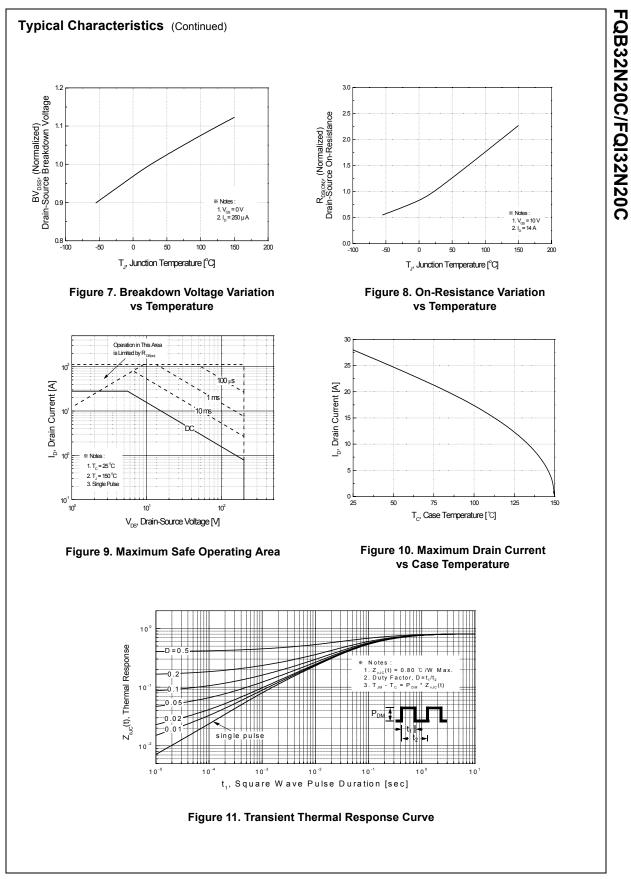
Thermal Characteristics

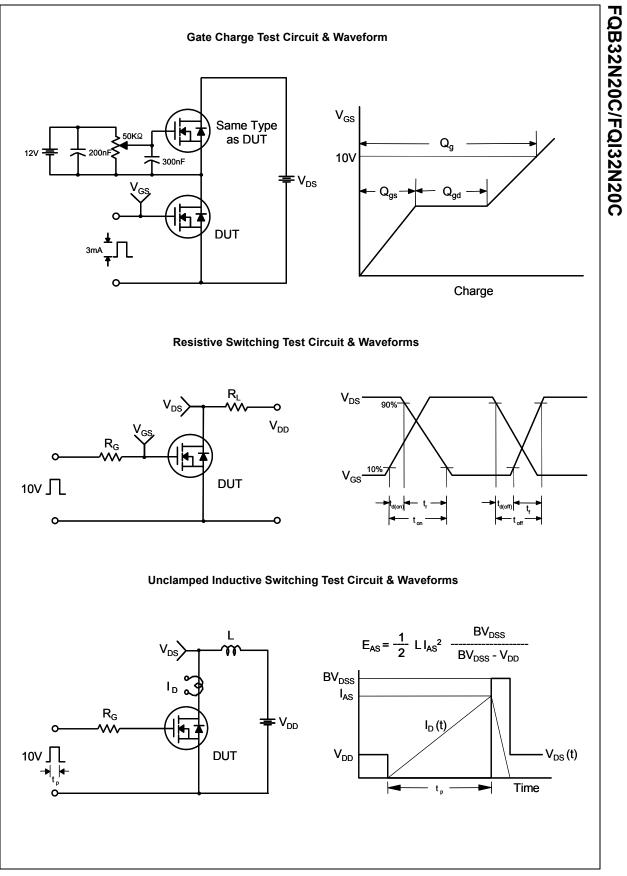
Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		0.8	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient*		40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

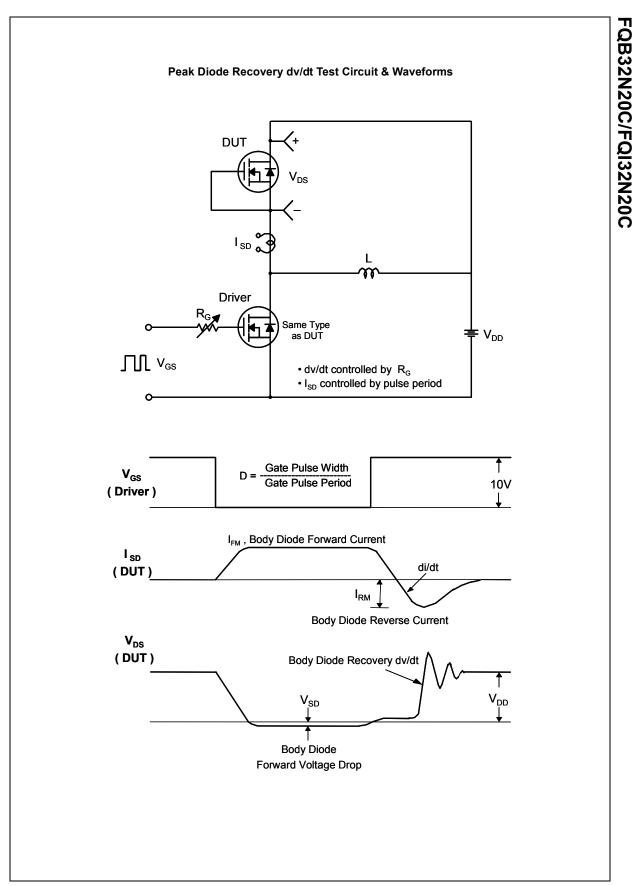
Symbol	Parameter	Test Conditions	S	Min	Тур	Max	Units
Off Cha	racteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 μA		200			V
ΔBV _{DSS} ΔTJ	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu A$, Referenced	to 25°C		0.24		V/°C
I _{DSS}		V _{DS} = 200 V, V _{GS} = 0 V				10	μA
	Zero Gate Voltage Drain Current	V _{DS} = 160 V, T _C = 125°C				100	μΑ
GSSF	Gate-Body Leakage Current, Forward	V _{GS} = 30 V, V _{DS} = 0 V				100	nA
GSSR	Gate-Body Leakage Current, Reverse	V_{GS} = -30 V, V_{DS} = 0 V				-100	nA
On Cha	racteristics						
/ _{GS(th)}	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = 250 μA		2.0		4.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 14 \text{ A}$			0.068	0.082	Ω
JFS	Forward Transconductance	V _{DS} = 40 V, I _D = 14 A	(Note 4)		20		S
	c Characteristics						
Piss	Input Capacitance	V _{DS} = 25 V, V _{GS} = 0 V, f = 1.0 MHz			1700	2220	pF
Poss Prss	Output Capacitance Reverse Transfer Capacitance				400 185	520 245	pF pF
d(on)	ng Characteristics Turn-On Delay Time	V _{DD} = 100 V, I _D = 32 A,			25	60	ns
					25	60	ns
r	Turn-On Rise Time	$R_{\rm G} = 25 \ \Omega$			270	550	ns
d(off)	Turn-Off Delay Time				245	500	ns
f	Turn-Off Fall Time		(Note 4, 5)		210	430	ns
ל ^g	Total Gate Charge	V _{DS} = 160 V, I _D = 32 A,			82.5	110	nC
ב _{gs}	Gate-Source Charge	V _{GS} = 10 V			10.5		nC
ב _{gd}	Gate-Drain Charge		(Note 4, 5)		44.5		nC
Drain-S	ource Diode Characteristics ar	nd Maximum Rating	S				
S	Maximum Continuous Drain-Source Dic	de Forward Current				28	Α
SM	Maximum Pulsed Drain-Source Diode F	Forward Current				112	Α
/ _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 28 A				1.5	V
rr	Reverse Recovery Time	V _{GS} = 0 V, I _S = 32 A,			265		ns
ג גע	Reverse Recovery Charge	dI _F / dt = 100 A/µs	(Note 4)		2.73		μC
r	Reverse Recovery Time	V _{GS} = 0 V, I _S = 32 A,	(Note 4)				ns
L = 1.4mH, I I _{SD} ≤ 28A, di Pulse Test :	ating : Pulse width limited by maximum junction temper $A_S = 32A$, $V_{DD} = 50V$, $R_G = 25 \Omega$, Starting $T_J = 25^\circ C$ $dt \le 300A/\mu s$, $V_{DD} \le 8V_{DSS}$, Starting $T_J = 25^\circ C$ Pulse width $\le 300\mu s$, Duty cycle $\le 2\%$ adependent of operating temperature	ature					

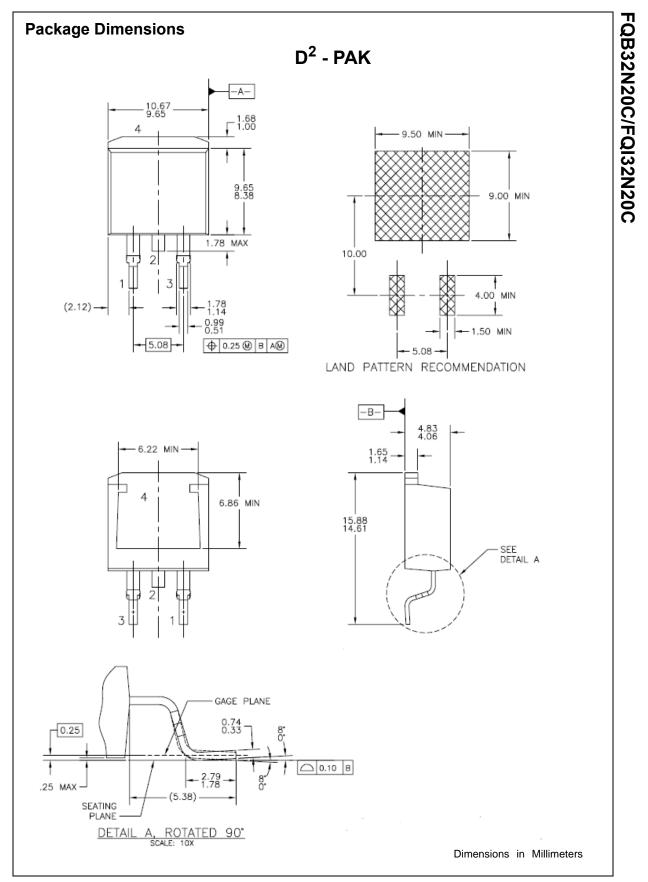
FQB32N20C/FQI32N20C

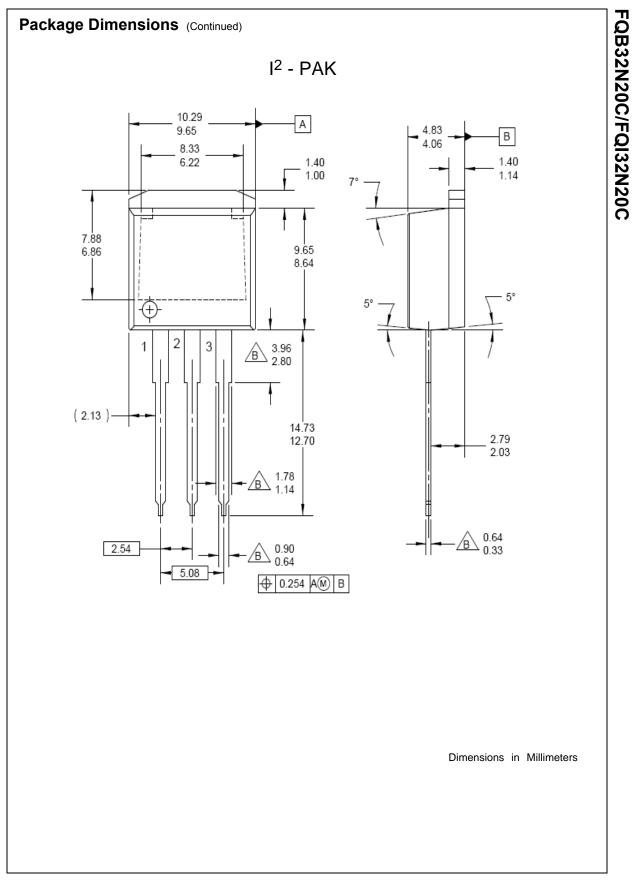














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